

# Search Notes



Application/Control No.

10/517,016

Examiner

Mark T. Le

Applicant(s)/Patent under Reexamination

OHASHI ET AL.

Art Unit

3617

## SEARCHED

Class	Subclass	Date	Examiner
213	1.3	12/06	~
	1.6		
	75GT		
	76		
105	3		
	4.1		
	4.2		
	4.3		
	4.4		
	159		
updated		4/07	~
105	157.1		
	182.1		
	206.1		

## INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
See Interference			
Search History	4/7		~

## SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
See EAST Search History	12/06	~
See Examination search History	4/07	~